

APPROVAL SHEET

WLPN505020 Series Shielded SMD Power Inductors

*Contents in this sheet are subject to change without prior notice.



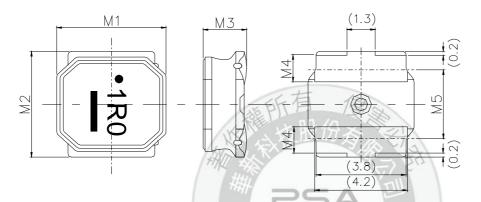
Features

- 1. Close magnetic loop with magnetic resin shielded.
- 2. Low profile, High inductance.

Applications

- 1. General propose power inductor in DC power system.
- 2. Inductor in DC/DC converter.
- 3. Low profile for portable and wearable device.
- 4. LC filter in Audio D class Amplifier.

Shape and Dimension



DIM. TOL. M1 4.9 ±0.2 M2 4.9 ±0.2 M3 2.0 MAX. M4 1.2 ±0.2

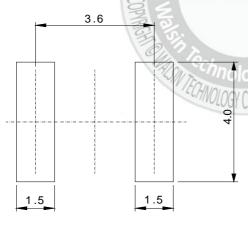
3.3

±0.2

UNIT: mm

М5

Recommended Land-Pattern





Ordering Information

WL	PN	5050	20	N	1R0	Р	В
Product Code	Series	Dimensions	Thickness	Tolerance	Value	Packing Code	
WL: Inductor	Shielded SMD Power Inductors	4.9 * 4.9 mm	2.0 mm	M: ± 20% N: ± 30%	1R0 = 1.0uH 100 = 10uH	P=7" Reeled (Embossed Tape)	B:STD

(): Reference value



Electrical Characteristics

WLPN505020	L (uH)	Inductance Tolerance	Test Freq (KHz)	DCR	SRF	Rated Current (mA) Max	
Series				(Ω ± 20%)	(MHz)Min	Saturation Current Idc1	Temperature Rise Current Idc2
WLPN505020N1R0PB	1.0	N	100	0.021	81	4000	3600
WLPN505020N1R5PB	1.5	N	100	0.026	68	3350	3200
WLPN505020N2R2PB	2.2	N	100	0.035	57	2900	2900
WLPN505020N3R3PB	3.3	N	100	0.048	46	2400	2400
WLPN505020M4R7PB	4.7	M	100	0.060	37	2000	2000
WLPN505020M6R8PB	6.8	M	100	0.090	30	1600	1650
WLPN505020M100PB	10	M	100	0.120	24	1300	1450
WLPN505020M150PB	15	M	100	0.165	20	1100	1200
WLPN505020M220PB	22	М	100	0.260	17	900	1000

1. Test Frequency: 100KHz.

2. Test Equipment:

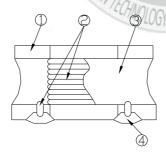
Inductance: Chroma3302+1320 or equivalent.

DCR: Chroma16502 or equivalent.

SRF: HP4291B or equivalent.

- 3. Saturation Current Idc1: The value of current causes a 30% inductance reduction from initial value.
- 4. Temperature rise current ldc2: The value of current causes a 40℃ temperature rise.
- 5. Rated Current: Either Idc1 or Idc2 whichever is smaller.
- 6. Operating Temperature Range:-25°C to +125°C (Including self-temperature rise).
- 7. Storage Temp. Range : -40°C to +85°C.
- 8. MSL: Level 1.

Structural Drawing



① Ferrite core : Ni-Zn ferrite.

② Winding wire: Polyurethane-copper wire.

③ Over-coating resin: Epoxy resin, containing ferrite powder.

Ag

Ni-Sn

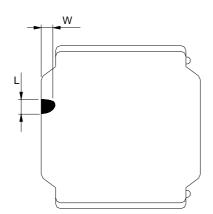
External electrode (base plating)

External electrode (top surface solder coating) Sn-Ag-Cu



Core Chipping:

The appearance standard of the chipping size in top side, of bottom side ferrite core is following dimension.

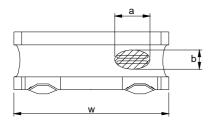


L	W
1.5mmMax.	1.5mmMax.



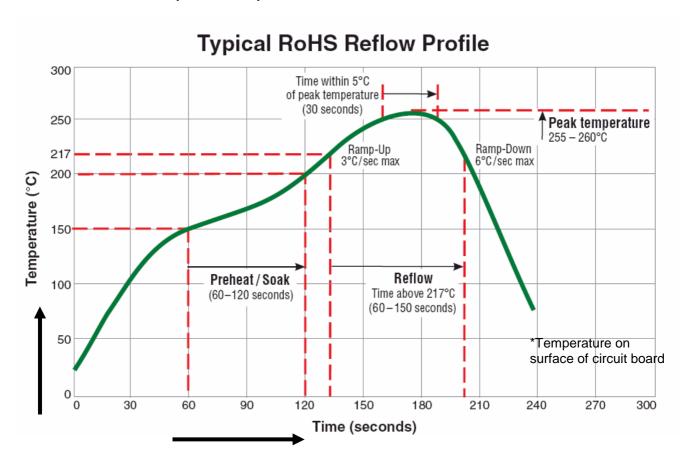


Exposed wire tolerance limit of coating resin part on product side Size of exposed wire occurring to coating resin is specified below.



- ① Width direction (dimension a): Acceptable when a<=w/2
 Nonconforming when a>w/2
- ② Length direction (dimension b): Dimension b is not specified.
- ③ When total area of exposed wire occurring to each sides is not greater than 50% of coating resin area, that is acceptable.

Reflow Profile Chart (Reference):



(Table 1)

The products may be exposed to reflow soldering process of above profile up to two times.



Mechanical Performance /Environmental Test Performance Specifications: (WLPN505020 series)

No.	Item	Test condition	Requirements					
	Resistance to Deflection.	No damage.	The test samples shall be soldered to the test board by the reflow soldering conditions show in Table 1. As illustrated below, apply force in the direction of the Arrow indicating until deflection of the test board Reaches to 2 mm.					
1			Force R230 5.1					
			R5 — Board C Test Sample 1.5 1.5					
			Land dimensions Test board size :100×40×10 Unit: mm Test board material I: glass epoxy-resin. Solder cream thickness:0.1					
	Adhesion of Terminal Electrode.	Shall not come off PC board.	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.					
2			Applied force: 10 N to X and Y directions Duration: 5 s. Solder cream thickness:0.1 mm. (Refer to recommended Land Pattern Dimensions Defined in					
			"Precaution")					
3	Body strength.	No damage.	Applied force :20 N. Duration :10 s. R0.5mm Sample					
	Resistance to Vibration.	△L/L:within±10% No abnormality observed In	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.Then It shall be submitted to below test conditions.					
		appearance.	Frequency range 10Hz~55Hz					
4			Total Amplitude 1.5mm(May not exceed acceleration 196 m/S2) Sweeping Method 10Hz to 55Hz to 10 Hz for 1 min.					
			Time For 2 hours on each X, Y, and Z axis.					
			, , , , , , , , , , , , , , , , , , , ,					
5	Resistance to Soldering heat (Reflow).	△L/L:within±10% No abnormality observed In appearance.	The test sample shall be exposed to reflow oven at 230±5 deg C for 40 seconds, with peak temperature at 260±5 deg C for 5 seconds, 2 times. Test board thickness:1.0 mm.					
			Test board material: glass epoxy-resin.					



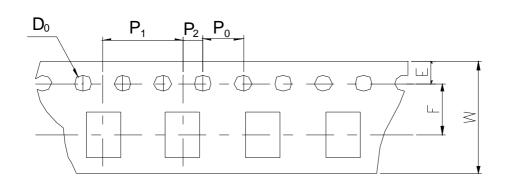
	Solder ability.	At least 90% of surface of terminal		samples shall Ider as show		•	hen Immerse	ed in
		electrode is		nanol solution		_		
6		covered by new solder.	Solder Temperature		245±deg C			
		Solder.	Time		5±1.0 S.			
			Immersin	g Speed	25 mm/s			
7	Temperature Characteristics.	△L/L:within±20% No abnormality observed in appearance	25 deg C	nent of inducta to +85 deg C. ence to induct l.				
	Thermal shock.	△L/L:within±10% No abnormality observed in appearance.	soldering The test s sequence The tempe	erature cycle	own in Table be placed at	e 1. specified s	hown in belo	
8				s of steps for		T: /	! \	
			Step 1	Tempera -40±3 de		Time(n 30±3		
			-					
			3	Room Temp		30±3	imum	
			4	· ·		3 maxir		
9	Low Temperature life Test.	△L/L:within±10% No abnormality observed in appearance.	soldering	ure	own in Table	e 1. placed at te	•	
10	Loading at high temperature life test.	△L/L:within±10% No abnormality observed in appearance.	The test s temperatubelow tabl	ature	own in Table be placed in d the rated of 85±2 deg (Rated curr (Refer to F	e 1. thermostaticurrent conti	ic oven set a	t specified
	David hast life	A 1 /1 '11' 400/	Time		500+24/-0			(1 - · · ·
11	Damp heat life test.	△L/L:within±10% No abnormality observed in appearance.	soldering The test s		own in Table be placed in	e 1. thermostati in below ta C	ic oven set a	
	Loading under	△L/L:within±10%		amples shall			oard by the	reflow
12	Damp heat life test.	No abnormality observed in appearance.	The test s temperatu as shown Tempera Humidity	soldering conditions shown in Table 1. The test samples shall be placed in thermostatic temperature and humidity and applied the rated of as shown in below table. Temperature 60±2 deg C Humidity 90~95%RH Applied current Rated current (Refer to F		d current con		
			Time		500+24/-0 h			
				current		•	o Page 3)	

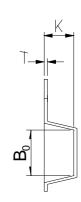


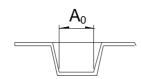
Tape & Reel Packaging Dimensions:

Dimensions

Unit: mm



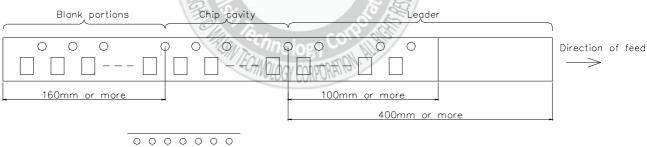




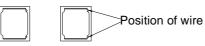
A_0	B ₀	W	F	EGG	有P1 g	P ₂	P_0	D_0	Т	K
5.25 ±0.1	5.25 ±0.1	12.0 ±0.3	5.5 ±0.1	1.75 ±0.1	8.0 ±0.1	2.0 ±0.1	4.0 ±0.1	Φ1.5 +0.1 -0	0.3 ±0.1	2.3 ±0.1

Direction of rolling

PSA
PASSIVE SYSTEM ALLIANCE

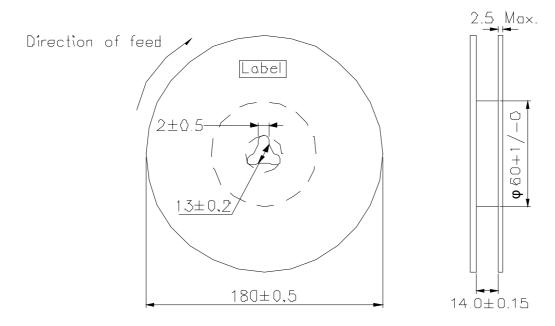


Direction of production insertion





Reel



Label position: on the opposite sie of sprocket holes side of reel



Peel-off strength: 0.1N~1.3N Peel-off angle:165°~180°

Peel-off speed: 300mm/mm

Quantity per reel: 0.8K pcs (800pcs)